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**APPLICATION
NOTE**

**Programming Flash Memory
through the Intel386™ EX Embedded
Microprocessor JTAG Port**

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1.0 INTRODUCTION

This application note describes a simple method for programming data into flash memory using a standard JTAG (Joint Test Action Group) port specified by IEEE 1149.1. The JTAG device used in this case is the Intel386™ EX embedded processor; however, the scope of this application is easily extended to many other JTAG compliant devices. Using the features of the Intel386 EX embedded processor in conjunction with a simple hardware interface, a standard set of software routines can be used to program data into flash memory. By controlling the CPU's JTAG port, these routines manage the data that is programmed into flash memory as well as the processor's control lines.

This document contains a general overview of:

- The basic functions specified by IEEE 1149.1
- The operation of the JTAG port of the Intel386 EX processor
- The features of the Intel 28F400BV-T 4-Mbit Boot Block device flash device

This application note also provides a functional design which can be used in conjunction with Revision 2.1 of the EV386EX Intel386™ EX Embedded Microprocessor Evaluation Board. The design consists of:

- A simple low-cost parallel port host interface design
- A standard set of JTAG C++ in-line assembly source code functions
- Source code that implements the programming, validation, and erasure of the contents of the Boot Block flash device

The compiled and executable code are available through Intel's America's Application Support BBS, at (916) 356-3600. They are contained in the file TAPLOADR.ZIP.

1.1 Design Motivation

As more packaged silicon devices populate printed circuit boards, the connection of test and programming equipment to the fine-pitch IC packages replacing socketed, broader-pitch parts becomes less feasible. Furthermore, the design of mobile equipment with even smaller form factors and more stringent shock tolerance requirements does not allow the designer to use sockets at all. The components in this case must be soldered directly onto the board to reduce manufacturing costs, improve reliability, and decrease the

space required by the hardware. Additionally, Just-In-Time manufacturing requirements make it desirable to solder unprogrammed devices, such as flash memory, onto printed circuit boards. This allows designers to customize the boards in their final stage, while reducing the amount of inventory that is required by the use of preprogrammed devices.

These constraints make the programming of bootstrap software and other firmware an even more formidable task than in the past. It is now desirable to download these integral pieces of the product into initially unprogrammed memories on the board in order to have the microprocessor up and running when it comes time to develop, test, and manufacture systems which take advantage of the latest advanced technologies. A good solution is to use a simple flash memory programming device that uses the Test Access Port (TAP) found on JTAG-compliant devices.

2.0 BACKGROUND INFORMATION

Designers unfamiliar with the features of the IEEE 1149.1 specification, the Intel386 EX embedded processor, or the Intel 28F400BV-T Boot Block flash will benefit from a brief overview of the features that these pieces provide. The design for programming flash memory shown in Figure 2 takes advantage of these features. The design uses:

- The five-wire interface of the TAP, which simplifies the hardware requirements
- The unique configuration of the Intel386 EX embedded processor in the embedded system to control flash memory programming
- The advanced programming algorithm of the Intel 28F400BV-T Boot Block flash device

This application note focuses on the 101-pin JTAG implementation found on the Intel386 EX embedded processor. Sections 2.1 and 2.2 describe this implementation, while the features of the Boot Block flash device are described in section 2.3.

2.1 IEEE 1149.1 - The JTAG Specification

The IEEE 1149.1 specification was originally intended to provide an easy way to verify the functionality and correct interconnection of both compliant and non-compliant devices in a printed circuit board design. However, without the presence of any firmware, the JTAG-compliant Intel386 EX embedded processor can imitate most of the bus signals

by controlling the TAP. This powerful feature can be used to access all of the peripherals as if an emulator or programmer were connected instead of the CPU.

The IEEE's official publication, the *IEEE Standard Test Access Port and Boundary-Scan Architecture*, contains a complete description of the JTAG standard and the operation of JTAG-compliant devices.

2.1.1 TAP Signal Descriptions

The TAP uses a serial synchronous data exchange protocol and consists of five signals:

- **TDI** - Test Data Input - a serial bit stream that goes into either the JTAG control/command registers or Boundary Scan Registers (BSR) that control the pin drivers register on the Intel386 EX processor.
- **TDO** - Test Data Output - a serial bit stream which goes to the tester and contains information shifted out of either the identifier register or the Pin Data Capture register of the JTAG unit.
- **TCK** - Test Port Clock - a synchronous clock which accompanies any data transfers through the JTAG port. Data on input lines is sampled on the rising edge of the TCK signal. Data on the output line is sampled on the falling edge of the TCK signal.

- **TMS** - Test Mode Select - this signal, used in conjunction with TDI, controls the state machine which determines the state of the TAP-related circuitry and the direction of data streams within the device under test.
- **TRST#** - Test Port Reset - an optional signal, implemented in the Intel386 EX processor, that resets the TAP state machine to the predetermined initial state.

2.1.2 JTAG State Machine

The movement of data through the TAP can be controlled by supplying the proper logic level to the TMS pin at the rising edge of consecutive TCK cycles. The TAP controller itself is a finite-state machine that is capable of 16 states. Each state contains a link in the operation sequence necessary to manipulate the data moving through the TAP. This includes applying stimuli to the pins, capturing incoming data, loading instructions, and shifting data into and out of the Boundary-Scan Register. Figure 1 shows the TAP state machine flowchart, and demonstrates the sequence of inputs on TMS necessary to progress from any one state to another. Asserting the TRST# pin at any time will cause the TAP to reset to the Test-Logic-Reset home state.



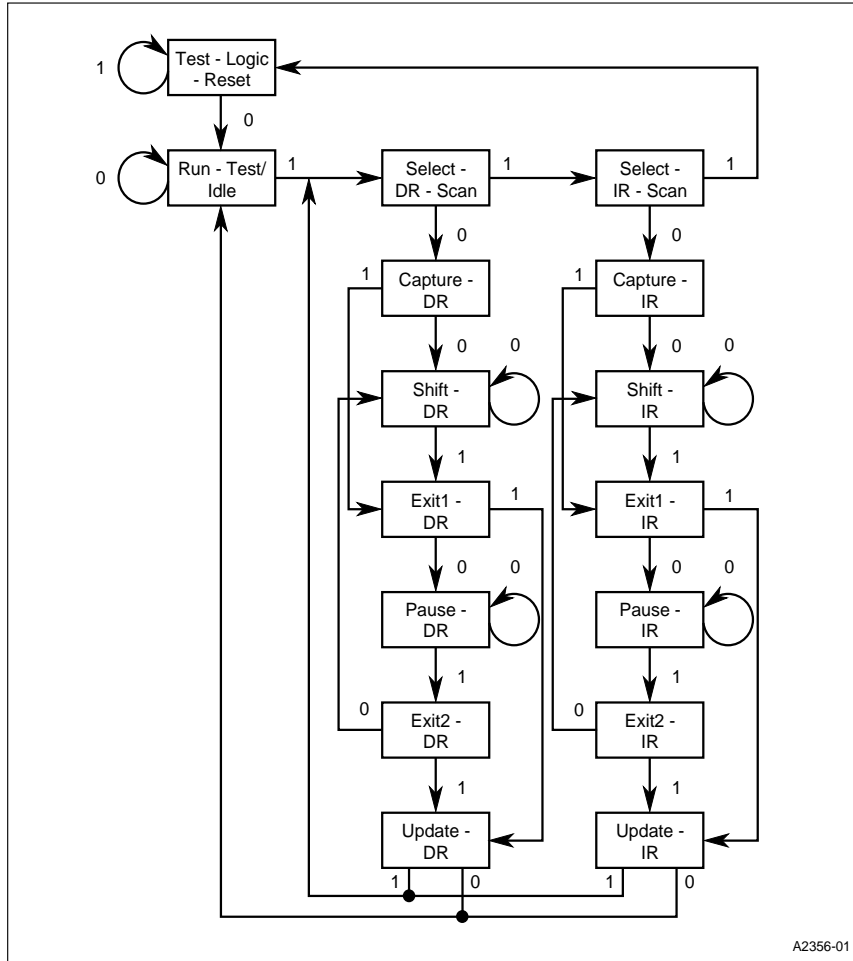


Figure 1. TAP Controller (Finite State Machine)

2.2 Intel386 EX Embedded Processor JTAG Test-Logic Unit

The JTAG Test-Logic Unit of the Intel386 EX embedded processor can control all device pins except those of the clock, power, ground, and TAP control signals. A boundary-scan cell resides at each of the 101 controlled device pins. The cells are connected serially to form the 101 bit boundary-scan register. Each bit has both a control cell, which controls the I/O status of the pin, and a data cell, which holds the logical high or low value to be asserted at the pin itself. An EXTTEST or INTTEST instruction, as

shown in Table 1, requires a total of 202 (101 bits x 2 cells) shifts of data into the TAP.

In addition to the boundary-scan (BOUND) register, the Intel386 EX processor has an instruction register (IR) whose instructions are shown in Table 1. These instructions are used in programming flash memory through the JTAG port. The bypass register (BYPASS) is also featured on the processor, but is only used in systems with two or more JTAG-compliant devices. The identification code (IDCODE) register is the last one implemented in the Intel386 EX processor, and is discussed further in Section 2.2.2.

Table 1. Test-Logic Unit Instructions

Mnemonic	Opcode ^{1,2}	Description
BYPASS	1111	Bypass on-chip system logic (mandatory instruction). Used for those components that are not being tested.
EXTEST	0000	Off-chip circuitry test (mandatory instruction). Used for testing device interconnections on a board.
SAMPRE	0001	Sample pins/preload data (mandatory instruction). Used for controlling (preload) or observing (sample) the signals at device pins. This test has no effect on system operation.
IDCODE	0010	ID code test (optional instruction). Used to identify devices on a board.
INTEST	1001	On-chip system test (optional instruction). Used for static testing of the internal device logic in a single-step mode.
HIGHZ	1000	High-impedance/ONCE mode test (optional instruction). Used to place device pins into their inactive drive states. Allows external components to drive signals onto connections that the processor normally drives.

NOTES:

- 1 The opcode is the sequence of data bits shifted serially into the instruction register (IR) from the TDI input. The opcodes for EXTEST and BYPASS are mandated by IEEE 1149.1, so they should be the same for all JTAG-compliant devices. The remaining opcodes are defined for use on the Intel386 EX embedded processor, so they may vary among devices.
- 2 All unlisted opcodes are reserved. Use of reserved opcodes could cause the device to enter reserved factory-test modes.

2.2.1 Boundary Scan Register

The order of the bits contained in the Boundary Scan Register (BSR) is shown in Table 2. The direction, or control, bits follow their corresponding data bits in the chain sequence. For example, Bit 0, M/IO# would be followed in the chain by its directional bit, which in turn would be followed by Bit 1, D/C#. It is important to remember that the boundary scan register is shifted in serially; when shifting data out onto the pins, the first bit shifted into the BSR must be the directional bit of D15 (entry number 100 in Table 2). This method ensures that all data is loaded onto the correct pins at the conclusion of the 202-bit serial data shift.

Although it is not used in the software examples included in Appendix A, a copy of the BSDL (Boundary-Scan Description Language) file for the A and B steppings of the Intel386 EX embedded processor (JTAGBSDL.ZIP) is

located on Intel's America's Application Support BBS, at (916) 356-3600. This file lists:

- The physical pin layout of all pins in the Boundary-Scan Register
- The valid and reserved JTAG unit opcodes
- The expected contents of the IDCODE register (shown also in Section 2.2.2) for the Intel386 EX embedded processor
- A description of the BSR contents

The BSDL file may be incorporated into software which uses the JTAG port for testing or programming functions. BSDL is a de-facto standard recently approved by the IEEE for describing essential features of IEEE 1149.1(b) compliant devices. A copy of the Intel386 EX embedded processor BSDL file is shown in Appendix B.



Table 2. Boundary-scan Register Bit Assignments

Bit	Pin	Bit	Pin	Bit	Pin	Bit	Pin
0	M/IO#	25	A15	50	TMROUT2	75	P2.2
1	D/C#	26	A16/CAS0	51	TMRGATE2	76	P2.3
2	W/R#	27	A17/CAS1	52	INT4/TMRCLK0	77	P2.4
3	READY#	28	A18/CAS2	53	INT5/TMRGATE0	78	DACK0#
4	BS8#	29	A19	54	INT6/TMRCLK1	79	P2.5/RXD0
5	RD#	30	A20	55	INT7/TMRGATE1	80	P2.6/TXD0
6	WR#	31	A21	56	STXCLK	81	P2.7
7	BLE#	32	A22	57	FLT#	82	UCS#
8	BHE#	33	A23	58	P1.0	83	CS6#/REFRESH#
9	ADS#	34	A24	59	P1.1	84	LBA#
10	NA#	35	A25	60	P1.2	85	D0
11	A1	36	SMI#	61	P1.3	86	D1
12	A2	37	P3.0/TMROUT0	62	P1.4	87	D2
13	A3	38	P3.1/TMROUT1	63	P1.5	88	D3
14	A4	39	SRXCLK	64	P1.6/HOLD	89	D4
15	A5	40	SSIORX	65	RESET	90	D5
16	A6	41	SSIOTX	66	P1.7/HLDA	91	D6
17	A7	42	P3.2/INT0	67	DACK1#/TXD1	92	D7
18	A8	43	P3.3/INT1	68	EOP#	93	D8
19	A9	44	P3.4/INT2	69	WDTOUT	94	D9
20	A10	45	P3.5/INT3	70	DRQ0	95	D10
21	A11	46	P3.6/PWRDOWN	71	DRQ1/RXD1	96	D11
22	A12	47	P3.7/SERCLK	72	SMIACT#	97	D12
23	A13	48	PEREQ/TMRCLK2	73	P2.0	98	D13
24	A14	49	NMI	74	P2.1	99	D14
						100	D15

NOTES:

- 1 Bit 0 is closest to TDI; bit 100 is closest to TDO.
- 2 The boundary-scan chain consists of 101 bits; however, each bit has both a control cell and a data cell, so an EXTEST or INTEST instruction requires 202 shifts (101 bits × 2 cells).



2.2.2 Identification Code Register

The IDCODE instruction allows the user to determine the contents of the device's identification code register. For the Intel386 EX embedded processor this command should return one of the values shown in Table 3.

Table 3. Device Identification Codes

Step	V _{CC}	IDCODE
A	5 V	0027 0013H
B	5 V	0027 0013H
C	5 V	2027 0013H
C	3 V	2827 0013H

For more information about identification codes, see the *Intel386™ EX Embedded Microprocessor User's Manual*.

2.3 Intel 4 Mbit Boot Block Flash

The number of instructions necessary to program flash devices is significantly reduced by using an Intel Boot Block device. In the sample design described in the next section, the automated Write State Machine (WSM) of the 28F400BV-T flash unit ensures that all algorithms and timings necessary for erasing and programming the device are executed automatically, freeing the TAP control software of additional burdensome I/O cycles and iterative code. The device also performs its own program and erase verifications, updating the Status Register (SR) to indicate the successful completion of operations. These features are standard with Intel's Boot Block, FlashFile™, and Embedded Flash RAM families, which are available in a variety of sizes and configurations.

Writing data to Intel's second-generation flash memories consists of these steps:

1. The write setup command (40H) is issued to flash memory.
2. This is followed by a second write specifying the address and data for the location to be written.
3. The data and address are latched internally on the rising edge of the WE# strobe, which may be issued by one of a variety of sources.

At this point, the WSM takes over, writing the results of the verification into the status register. Since data access is much slower than the typical programming time, the contents of the SR need not be checked after each write. Instead, writes are repeated sequentially for all locations to be programmed, with the SR verified when the block programming is completed. After the device is programmed, the data may be read back sequentially with RD# held constantly low, and the contents may be verified by comparison against the source code.

The static nature of the Intel386 EX embedded processor's Boundary Scan Register outputs combined with the high speed of the flash device ensures that timing issues are a minimal problem. In fact, a 16-bit word may be written to the flash device in only a single cycle of the boundary scan register. This is accomplished by using an additional output pin of the controlling PC's parallel port connected to WE# to clock the data and address into the chip. By doing so, as is discussed in Section 4.0, PERFORMANCE ANALYSIS AND CONSIDERATIONS, even a simple design can achieve throughput levels of more than 1 Kbyte per second through the serial BSR of the Test Access Port.

3.0 SAMPLE DESIGN

3.1 TAP Hardware Interface

Figure 2 illustrates a straightforward design that uses a standard parallel port to communicate with the TAP of the Intel386™ EX Embedded Microprocessor Evaluation Board. This interface is typical of any design based on the Intel386 EX embedded processor, and requires only a CMOS buffer to protect the TAP pins and translate the printer port signals to the CMOS levels required for the TAP. This assembly can be built onto a simple cable or card that plugs into the Intel386 EX Embedded Microprocessor Evaluation Board Option Header. It receives power and ground signals from the Evaluation Board, which must be powered on during operation of the TAP programmer. The majority of the signal control is done by software routines which read and write data to and from the BSR.



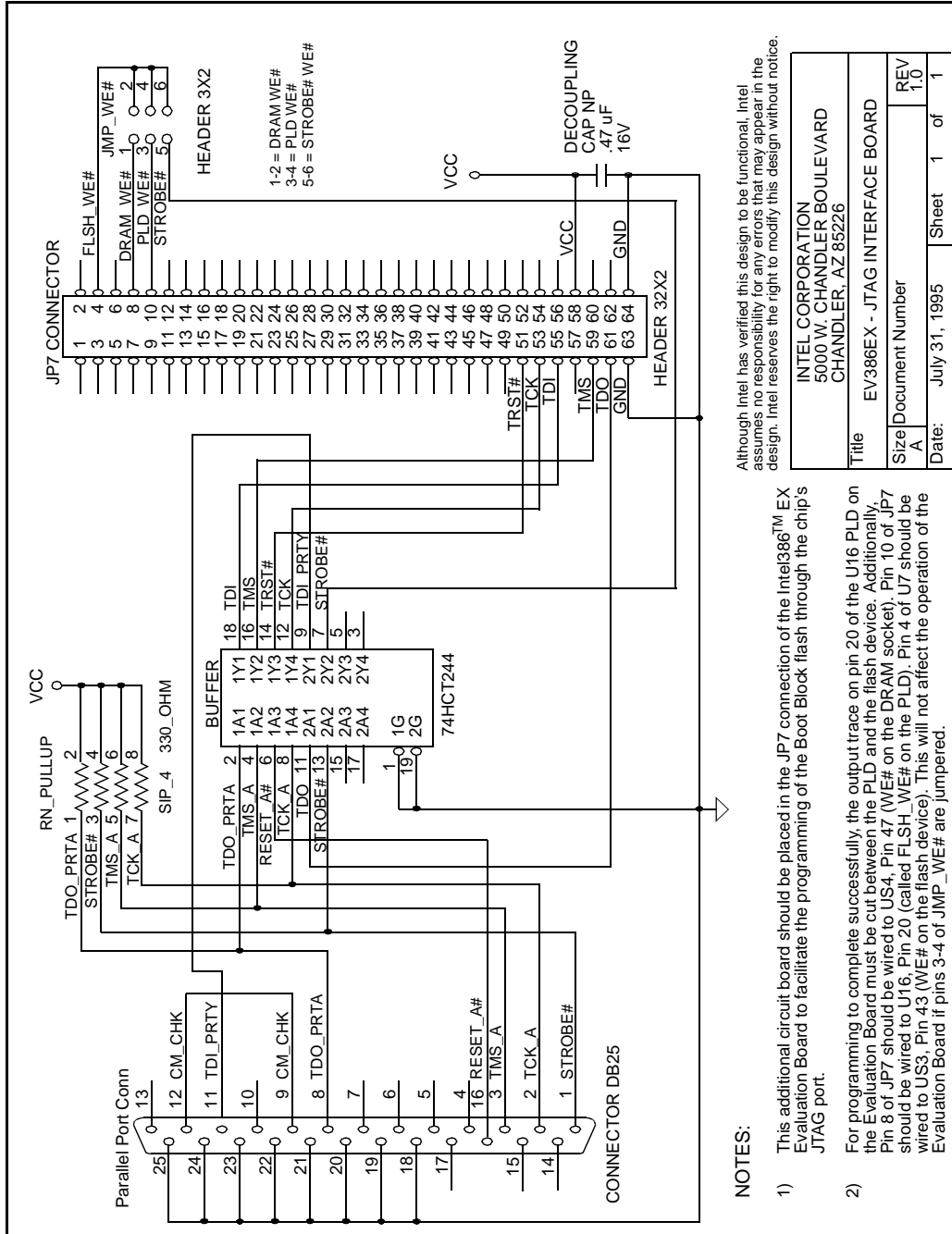


Figure 2. TAP Parallel Port Interface

3.2 JTAG Software Interface

This section details the operation of the various software routines that use the Test Access Port to program data into the Boot Block flash. The source code for the executable program TAPLOADR.EXE, which contains both inline assembly routines as well as C language functions, is shown in Appendix A. The software demonstrates how to:

- Configure and modify the status of pins for data input and output
- Shift in the values necessary to perform I/O to the flash device
- Perform operations such as status checks and data I/O

3.2.1 Hardware Considerations

The high-level routines used in programming data through the TAP are device-dependent because they assume a particular device configuration on the board as well as a predetermined system interface. In the example, the JTAG chain contains only a single IEEE 1149.1 compliant device, the Intel386 EX embedded processor. If the JTAG chain consisted of several devices connected in series, the routines would need to control the whole chain and place any other devices into the BYPASS mode. The routines in the example assume only a single device with separate RD# and WR# strobes generated by the CPU. The WR# signal may be enabled externally to improve performance; this is discussed in Section 4.0, PERFORMANCE ANALYSIS AND CONSIDERATIONS.

Several preparations must be made before the flash memory can be programmed. On the Evaluation Board, JP12 must be installed and R12 removed. Jumpering pins 1 and 2 of JP12 enables the PWD signal (pin 44) of the 28F400BV-T flash device, which provides programming voltage for block erases and writes. When programming the flash, it is also critical to enable V_{pp} (pin 1) by setting Port 1.5 (pin 107) of the Intel386 EX embedded processor on the Evaluation Board used in the example.

In the example, UCS# is used as the chip select (CS#) for the flash device; it is LOW for any address that is accessed. The example also implies static behavior of the bus; therefore, the connection of flash chips to the CPU should be independent of any clocks. If any buffers on the busses are required in the design, their direction and enable signals should be static. Take care to ensure that all flash control signals are clock-independent. Revision 2.1 of the EV386EX Intel386TM EX Embedded Microprocessor

Evaluation Board requires that a change be made to temporarily disconnect the output of Pin 20 of the U16 PLD (FLSH_WE#) so that the flash's WE# signal may be controlled by an external, static, and clock-independent source. Examples are shown in Figure 2 for Parallel Port and TAP control of the WE# signal. Making the changes described in the figure notes enables the correct operation of the programming functions and eliminates any contention for control of the devices and their signals.

Future steppings of the Intel386 EX embedded processor remove the need for PLD control of the flash's WE# signal by correcting errata #29 of the Intel386 EX embedded processor errata list. This allows a glueless flash interface to be used in some designs and eliminates the need for modifications to the PLD when implementing the programming of the flash memory through the TAP. When cutting the trace on the FLSH_WE# signal, however, care must be taken to jumper pins 3-4 on the JTAG interface card so that correct operation of the EV386EX evaluation board is retained.

Although two examples are given for resetting the JTAG unit of the Intel386 EX embedded processor, it is only necessary to use one of the provided means to return the TAP state machine to Test-Logic-Reset. If the chosen implementation uses the Restore_Idle function rather than the Reset_JTAG routine, it is advisable to tie an inverted CPU Reset signal to the TRST# input of the processor. This guarantees that the TAP relinquishes control of all the controlled CPU pins upon a system reset. If the Reset_JTAG function is used, care must be taken to reset the system immediately after TRST# is asserted.

3.2.2 Assembly Language Routines

The heart of the software that allows you to program flash through the JTAG port is contained in the assembly routines which control the JTAG unit of the Intel386 EX embedded processor via the parallel port of a PC. These routines have been implemented as inline assembly code to simplify the development process and the clarity of the software. They use a set of bit masks and variables shown in the first section of Appendix A under the heading "Assembly Language Variables." A description of each function is shown below:

- **Reset_JTAG** - Resets the TAP to the Test-Logic-Reset state by toggling the TRST# signal. This signal is optional in IEEE 1149.1, but has been provided on the Intel386 EX embedded processor. Alternately, the same



function is provided by five consecutive TCK periods with TMS held high. See `Restore_Idle` (below) for more details.

- **Restore_Idle** - Resets the TAP to the Test-Logic-Reset state by transitioning through the state machine. TMS is held high for five consecutive TCK clock periods. This is in accordance with the IEEE 1149.1 specification.
- **TMS_High** - Provides a vehicle for progression through the state machine with TMS held high for a single TCK clock period. Used when shifting data into and out of the TAP.
- **TMS_Low** - Provides a vehicle for progression through the state machine with TMS held low for a single TCK clock period. Used when shifting data into and out of the TAP.
- **Shift_Data_Array** - Shifts a data string into the TAP while copying the data in the TAP into the place of the incoming data. This function is called when the TAP state machine is in the `Select_DR_Scan` state.
- **Shift_Data_Array_IN** - Shifts a data string into the TAP and does not copy any data from the TAP in the place of the incoming data. This function is called when the TAP state machine is in the `Select_DR_Scan` state.
- **Strobe_Data_In** - Pulses the `STROBE#` line of the PC's parallel port. This function is used only when `STROBE#` is connected to the `WE#` line of the flash.
- **Send_Data** - Sends a JTAG data string into the TAP. Replaces the original string with the data that is shifted out on TDO.
- **Send_Data_IN** - Sends a JTAG data string into the TAP. Does not replace the original string with the data that is shifted out on TDO.
- **Flip_ID_String** - Flips the JTAG unit ID string within its own array. This needs to be done in order to reverse the string which is read in backwards, least significant bit first. This allows for verification of the data that is read against the value shown in the *Intel386™ EX Embedded Microprocessor User's Manual*, most significant bit first.
- **Get_JTAG_Device_ID** - Retrieves the JTAG device ID from the processor. Displays the results and the expected value.
- **Fill_JTAG** - Initializes the values in the 202 bit JTAG BSR array for a standard configuration. Sets up input and output pins and values for the control pins in the BSR. Sets the direction bits of the unused pins to a value of "0" which makes them inputs. This routine is unique to the Intel386 EX embedded processor and must be configured differently for other devices.
- **Set_Data** - Decodes a 16-bit data word onto the D0 through D15 data lines in the BSR array. Sets the data line directional bits to a value of "1" which makes them into outputs. Used when writing data to the flash.
- **Get_Data** - Configures the data lines as inputs, allowing data to be output from the flash and read into the BSR array. Used when reading data back from the flash.

3.2.3 "C" Routines

Appendix A contains a number of "C" language functions that make the programming of flash modular and easy to implement. Many of them are called from the "Main" function of `TAPLOADR.EXE`, but others are used to move data back and forth into the TAP by means that would be complicated by using assembly language programming. The program was compiled under Microsoft® Visual C++ 1.50. A list of the functions, their dependencies, and a brief description of their operation is given below.

- **Send_Instruction** - Sends a JTAG instruction as a string into the TAP. Replaces the original string with the data that is shifted out on TDO.
- **Send_Instruction_IN** - Sends a JTAG instruction as a string into the TAP. Does not replace the original string with the data that is shifted out on TDO.
- **Parse_Data** - Reads the data from the data lines in the BSR array and parses it into a 16-bit data word. Used when reading data back from the flash.
- **Set_Address** - Decodes an address onto the A1 through A25 data lines in the BSR array. Sets the directional bits for the address lines to a value of "1" which makes them into outputs. Used for both reads and writes to and from the flash.
- **Flash_Read** - Reads a 16-bit data word from the flash device at the specified address. Used for verification of data and status checks.
- **Flash_Write** - Writes a 16-bit data word to the flash device at the specified address. Used for data programming and status checks. Optional section within this procedure may be chosen depending on

chosen method of WE# hardware control. Only one type of WE# signal enabling procedure may be used at a time.

- **Input_File_Name_OK** - Verifies that the input file is a file that can be read. When this function does not return a value of TRUE, the program displays an error message and prompts the user to try executing the program again. If the file is valid, the program executes normally.
- **Get_Flash_Device_ID** - Retrieves the flash device ID from the Intel Boot Block flash Device. Displays the results and the expected value.
- **Check_Flash_Status** - Clears the flash status registers and sends a Read Status command to the device. The results are read back and displayed along with the expected values for a properly functioning device.
- **Erase_Flash** - Erases each block within the Intel Boot Block flash device. An address within each block is stored in an array in this function, and the function loops for a specified number of blocks, seven in this case. The function may be altered to erase only the Boot Block or selected blocks within the device.
- **Program_Flash_Data** - Outputs data from the specified binary input file to the flash device. Data is read in as 8-bit characters and is merged into 16-bit words which are then written to the Flash device. Status checks are not performed after each write, because doing so slows performance. The function displays the status of a successful programming operation and notifies the user if the input file has been closed successfully.
- **Read_Flash_Data** - Reads back the data that has been written to the flash into the file VERIFY.BIN. A file comparison may be done to check the correct programming of flash data. This is unnecessary in most real applications, but is marginally faster than checking status after each word is programmed.

3.2.4 Program Operation and Options

TAPLOADR.EXE operations are controlled from the program's "Main" function. The program does not execute until it is given a valid input file name. Table 4 lists the functions which verify, write, and then read back the data in the file that is written to the flash device.

Table 4. TAPLOADER.EXE Order of Execution

Input_File_Name_OK (input_file)	// Checks input file name
Fill_JTAG(PinState);	// Initialization string
Reset_JTAG();	// Reset the JTAG unit
Restore_Idle();	// Used to reset JTAG state machine
Get_JTAG_Device_ID();	// Get ID - see 386EX manual for code
Get_Flash_Device_ID();	// Get ID - see flash manual
Check_Flash_Status();	// Check status register example
Erase_Flash();	// Erases the entire flash chip
i = Program_Flash_Data();	// Opens file and programs flash data
Check_Flash_Status();	// Checks status before continuing
Read_FLASH_Data("verify.bin", data_start_address, i);	// Copy contents to file



The program displays status check messages throughout its operation. It is important to recognize that some operations, especially when programming large amounts of data, may take from a few seconds to a few minutes to complete. A block erase operation normally requires approximately 0.5 seconds per block, or about 4 seconds per flash device. Writing data may take from just a few seconds to over 30 minutes, depending on the size of the input file and the methods used for verifying data programming and enabling WE# on the flash chip. These issues are discussed in the next section.

4.0 PERFORMANCE ANALYSIS AND CONSIDERATIONS

A number of factors can affect the performance, specifically the throughput levels, of any programming device that uses

the JTAG port. Among these, the most critical are the methods used to write the data into the flash device and verify that it has been successfully stored at the correct location.

As was mentioned earlier, reducing the number of status checks performed while programming can greatly reduce the time required to program data into flash. The relatively slow operation of the parallel port and TAP combination ensures that read and write operations do not interfere with those that precede them. Checking status bits only at the end of blocks of writes can reduce programming time by as much as one half. Table 5 shows a comparison of typical timings measured while loading data into the flash device found on the Intel386™ EX Embedded Microprocessor Evaluation Board.

Table 5. TAP Flash Programming Sample Timings

Size of Operation	Type of Access	Status Check	FLSH_WE# Type	Seconds	Seconds/Kbyte
32 Kbyte	Write	Yes	WE#	180	5.62
32 Kbyte	Read	N/A	WE#	40	1.25
32 Kbyte	Write	No	WE#	100	3.12
32 Kbyte	Read	N/A	WE#	40	1.25
32 Kbyte	Write	No	STROBE#	45	1.41
32 Kbyte	Read	N/A	STROBE#	40	1.25
512 Kbyte	Write	Yes	WE#	2940	5.74
512 Kbyte	Read	N/A	WE#	660	1.28
512 Kbyte	Write	No	WE#	1620	3.16
512 Kbyte	Read	N/A	WE#	660	1.28
512 Kbyte	Write	No	STROBE#	555	1.08
512 Kbyte	Read	N/A	STROBE#	590	1.15

Table 5 also illustrates how the use of a WE# generated by the STROBE# line of a typical parallel port may expedite the delivery of data through the TAP. Using this method allows writes to complete in a single cycle of the TAP, rather than the normal three cycles that are required when strobing the WE# signal from the TAP. As shown in Appendix A, the data and address are placed on the bus in a single cycle when using STROBE# as WE#. They are then clocked into the flash device by toggling the STROBE# line externally. In the latter case, however, three complete shifts of the BSR data must be performed in order to send the data

and address and simultaneously toggle the WE# line in a similar high-low-high pattern. Reductions in write cycle time of close to two thirds are expected when using the first method. The unused data signals of the parallel port may also be used to control other useful signals such as RD#, or to monitor the status of control lines on the system under test.

It is worth mentioning that several companies currently offer JTAG port interface cards that use a standard ISA bus interface to communicate with one or more Test Access



Ports. These cards can vastly improve the data transfer rates of about 0.5 Kbytes per second that are typical of a parallel port programmer. Although this rate is comparable to that of a typical EPROM programmer, TMS periods on the order of a few microseconds are less than ideal. Typical data rates of 8 Mbits per second may be achieved by a simple card which uses RAM to send and read data patterns from the JTAG port. Since the bus signal emulation requires only the toggling of a few signals out of all that are within the BSR, the card stores the data to be written and transfers it to the TAP in a rapid manner. Most hardware vendors provide a library of software to assist the programmer in writing code to interface with such cards. Even the simplest combination of hardware and software can be a valuable tool in programming and testing new code in flash.

5.0 CONCLUSION

The Intel386 EX processor provides a powerful means of programming onboard flash devices to meet the needs of Just-In-Time manufacturing systems. Unprogrammed devices may now be soldered directly onto PCB's, allowing for concurrent software and hardware development processes as well as last minute changes in BIOS code

without the loss of valuable time or inventory. Accessing these devices via the chip's IEEE 1149.1-compliant Test Access Port provides an inexpensive, versatile, and reliable tool that functions far beyond the realms of debug and test. If shock-tolerance and reduction of form-factor are primary design concerns, using the JTAG port is sure to be an important tool for in-circuit device reprogramming and reconfiguration. The parallel port of a standard PC becomes a flexible tool in this case, and may be used to generate TAP signals for either lab or low-volume production. With a high-performance solution based on a simple TAP controller card in a PC, programming performance significantly improves without the purchase of costly test equipment.

6.0 RELATED INFORMATION

This application note is one of the many sources of information available regarding designing with the Intel386 EX embedded processor. Table 6 shows other useful documents and their Intel order numbers.

Table 6. Related Intel Documents

Publication Title	Order Number
<i>Intel386TM EX Embedded Microprocessor datasheet</i>	272420
<i>Intel386TM EX Embedded Microprocessor User's Manual</i>	272485
<i>Intel386TM SX Embedded Microprocessor datasheet</i>	240187
<i>Intel386TM SX Embedded Microprocessor Programmer's Reference Manual</i>	240331
<i>Intel386TM SX Embedded Microprocessor Hardware Reference Manual</i>	240332
<i>186 Development Tools Handbook</i>	272326
<i>Intel386TM EX Embedded Microprocessor Evaluation Board Manual</i>	272525
<i>Buyer's Guide for the Intel386TM EX Embedded Processor Family</i>	272520
<i>Packaging</i>	240800
<i>1995 Flash Memory Databook</i>	210830





To receive these documents or any other available Intel literature, contact:

Intel Corporation
Literature Sales
P.O. Box 7641
Mt. Prospect IL 60056-7641
1-800-879-4683

To receive files that contain the source code, executable programs, and schematics for this application of flash programming through the TAP, contact:

Intel Corporation
America's Application Support BBS
916-356-3600

Additional information on the IEEE 1149.1/1a specification may be found in the official IEEE Standards document *IEEE Standard Test Access Port and Boundary-Scan Architecture*. This publication is sponsored by the Test Technology Standards Committee of the IEEE Computer Society and is available from:

Institute of Electrical and Electronics Engineers, Inc.
345 East 47th Street
New York NY 10017





APPENDIX A PROGRAM SOURCE CODE

The following source code was written in Microsoft Visual C++ version 1.5 and has been tested using the aforementioned hardware interface on a Intel386™ EX Embedded Processor Evaluation Board. It was compiled and linked into the file TAPLOADR.EXE, which is available on Intel's America's Application Support BBS in the zipped file TAPLOADR.ZIP.

Table A-1. Program Source Code (Sheet 1 of 15)

```
/****** TAPLOADR.CPP *****/
*
* Program Name: TAPLOADR.CPP
*
* Version: 1.0
*
* Date: July 18, 1995
*
* Author: Daniel S. Hays
* 386 Applications Engineer
*
* References: Excerpts of code taken from modules of the article
* "Beyond the Myth of JTAG Boundary Scan Port" by Dmitrii
* Loukianov, Intel Corp., 1995.
*
* Program Spec: This program will take an input flash file residing on a PC
* and program it into the boot block flash of the 386EX
* Evaluation Board utilizing the JTAG unit onboard the 386EX
* embedded processor. It will also erase the entire FLASH
* chip beforehand, including the boot block area, if
* enabled as described in the requirements section below.
*
* Requirements: In addition to the eval board itself, it is required that
* the user has a JTAG interface board plugged into both the
* evaluation board's expansion bus slot and the host PC's
* parallel port. The U16 PLD chip must be updated in order to
* disable the FLASH_WE# signal, and a jumper must be installed
* on pins 1-2 of Jumper J12, which is not normally populated
* on the standard eval board.
*
* *** Note: The power supply for the 386EX eval board must be
* ON in order for successful programming of the flash to take
* place. The program implies that UCS is the CS# pin for flash
* memory being programmed. UCS is set LOW for any address!
*
* The user must also know the location and name of the input
* data file in .BIN format, as well as the starting location
* in FLASH memory that the file is to be located at.
*
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```

Table A-1. Program Source Code (Sheet 2 of 15)

```

*
***** GLOBAL DECLARATIONS *****/

#include <stdio.h>
#include <string.h>
#include <stdlib.h>
#include <conio.h>

/**** Definitions of JTAG BSR pins for sequence for Intel 386 EX CPU ****/
/***** Note: MIO shifted out LAST, D15 - first! *****/

#define D15 0
#define D14 1
#define D13 2
#define D12 3
#define D11 4
#define D10 5
#define D9 6
#define D8 7
#define D7 8
#define D6 9
#define D5 10
#define D4 11
#define D3 12
#define D2 13
#define D1 14
#define D0 15
#define LBA 16
#define CS6 17
#define UCS 18
#define P27 19
#define P26 20
#define P25 21
#define DACK0 22
#define P24 23
#define P23 24
#define P22 25
#define P21 26
#define P20 27
#define SMIACK 28
#define DRQ1 29
#define DRQ0 30
#define WDOUT 31
#define EOP 32
#define DACK1 33
#define P17 34
#define RESET 35
#define P16 36
#define P15 37
#define P14 38
#define P13 39
#define P12 40
#define P11 41
#define P10 42
#define FLT 43
#define STXCLK 44
#define INT7 45
#define INT6 46
#define INT5 47
#define INT4 48
#define TMRGATE2 49
#define TMRGATE1 50

```

Table A-1. Program Source Code (Sheet 3 of 15)

```

#define NMI 51
#define PEREQ 52
#define P37 53
#define P36 54
#define P35 55
#define P34 56
#define P33 57
#define P32 58
#define SSIOTX 59
#define SSIORX 60
#define SRXCLK 61
#define P31 62
#define P30 63
#define SMI 64
#define A25 65
#define A24 66
#define A23 67
#define A22 68
#define A21 69
#define A20 70
#define A19 71
#define A18 72
#define A17 73
#define A16 74
#define A15 75
#define A14 76
#define A13 77
#define A12 78
#define A11 79
#define A10 80
#define A9 81
#define A8 82
#define A7 83
#define A6 84
#define A5 85
#define A4 86
#define A3 87
#define A2 88
#define A1 89
#define NA 90
#define ADS 91
#define BHE 92
#define BLE 93
#define WR 94
#define RD 95
#define BS8 96
#define READY 97
#define WRD 98
#define DC 99
#define MIO 100

#define TRUE 1
#define FALSE 0

typedef unsigned int word; // 16 Bit word
typedef unsigned char byte; // 8 Bit Byte
typedef char *Pchar;
typedef Pchar PJTAGdata; // JTAG Data array / null term string

const word BSR_Length=202; // # bits in JTAG BSR string 101x2
const word ID_String_Length=32; // # bits in JTAG CPU ID String

unsigned long int A; // Stores address data

```

Table A-1. Program Source Code (Sheet 4 of 15)

```

unsigned long int i; // Stores index value
unsigned long int data_start_address; // Holds starting address of program
word RX; // Stores register data
word new_word; // Holds word to be written to FLASH
word high_part; // Temp Holder for upper part of word
char PinState[BSR_Length]; // Holds Pin Data to move in and out
char input_file[80]; // Holds name of input file
int c; // Holds character being worked with
FILE *in; // Points to input file location

/***** JTAG1149 Commands for Intel386EX Embedded Processor *****/

char *BYPASS = "1111"; // Use BYPASS register in data path
char *EXTTEST = "0000"; // External Test Mode
char *SAMPLE = "1000"; // Sample/Preload Instruction
char *IDCODE = "0100"; // Read ID CODE from the chip
char *INTTEST = "1001"; // On-chip System Test
char *HIGHZ = "0001"; // Place device into Hi-Z mode

/***** Assembly language variables *****/

#define TCK 1; // Bit 0 is TCK output
#define TMS 2; // Bit 1 is TMS output
#define TCKTMS 3; // Bit 0+1
#define TDI 0x40; // Bit 6 is TDI output
#define notTCKTMS 0xFC; // Bit 0+1
#define TDI_TMS 0x42; // Bit TDI+TMS
#define TRST 4; // JTAG+2
#define TDO 0x80; // JTAG+1, bit is inverted!

static word JTAG=0x378; // LPT1 Data Address Default
const word JTAGI=JTAG+1; // Contains circuit input
const word JTAGR=JTAG+2; // Reset bit is here

/*****
***** INLINE ASSEMBLER FUNCTIONS FOR JTAG I/O *****/
*****

/***** Assembly function to reset the JTAG unit *****/

void far Reset_JTAG() /** Reset TAP logic by optional TRST# signal **/
{
    _asm
    {
        mov dx,JTAG
        mov al,0 // +TDI
        out dx,al
        mov dx,JTAGR
        mov al,0 // TRST# LOW
        out dx,al
        mov dx,JTAGR
        mov al,TRST // TRST# HIGH
        out dx,al
    }
}

/***** Assembly function to go into Run_Test_Idle state from unknown state **/

void far Restore_Idle () /** Restore Test_Logic_Reset state by 5 TCK's **/
{
    /** Goes into TLR state from any **/
    /** unknown state of the JTAG controller **/

    _asm
    {

```

Table A-1. Program Source Code (Sheet 5 of 15)

```

        mov     cx,5
        mov     dx,JTAG

FiveTimes:

        mov     al,TMS           // TMS HIGH
        out     dx,al           // Set TMS/TDI
        or      al,TCK
        out     dx,al           // TCK High
        xor     al,TCK           // TCK Low
        out     dx,al
        loop   FiveTimes
    }
}
/***** Assembly function to do one transition with TMS High *****/
void near TMS_High () /** One transition with TMS High **/
{
    _asm
    {
        mov     dx,JTAG
        mov     al,TMS           // Sets TMS high
        out     dx,al           // Set TMS/TDI
        or      al,TCK
        out     dx,al           // TCK High
        xor     al,TCK           // TCK Low
        out     dx,al
    }
}
/***** Assembly function to do one transition with TMS Low *****/
void near TMS_Low () /** One transition with TMS Low **/
{
    _asm
    {
        mov     dx,JTAG
        mov     al,0             // Set TMS Low
        out     dx,al           // Set TMS/TDI
        or      al,TCK
        out     dx,al           // TCK High
        xor     al,TCK           // TCK Low
        out     dx,al
    }
}
/***** Assembly function to shift data into JTAG port while reading *****/
void near Shift_Data_Array(unsigned S, char far *D)
{
    /** Shifts data String into JTAG port while reading data **/
    /** from JTAG port back into D, **/
    /** The procedure should be called when JTAG controller **/
    /** is in the SelectDRScan state **/

    _asm
    {
        mov     dx,JTAG
        push    es
        push    di
        les     di, D           // Get array pointer
        cld
        xor     ax,ax
        mov     ax, S           // Get Size
        dec     ax
    }
}

```

Table A-1. Program Source Code (Sheet 6 of 15)

```

mov     cx,ax
jz      LastClock3

I_Shift3:

mov     al, byte ptr es:[di]
shl     al,6
and     al, notTCKTMS // Clear TCK and TMS bits
out     dx,al // Put first data bit
or      al,TCK // Set TCK high
out     dx,al // Shift in first data bit

inc     dx // Sample first data bit

in      al,dx
and     al,80h
mov     al,'1'
je      Ex_1
mov     al,'0'

ex_1:
stosb
dec     dx
loop   I_Shift3

LastClock3:

mov     al, byte ptr es:[di]
shl     al,6
and     al, notTCKTMS
or      ax, TMS // Set TMS bit
out     dx,al // Put last data bit
or      al,TCK // Set TCK high
out     dx,al // Shift in first data bit

inc     dx // Sample first data bit

in      al,dx
and     al,80h
mov     al,'1'
je      Ex_2
mov     al,'0'

ex_2:
stosb

dec     dx

mov     al,TDITMS // Leave TCK pin Low
out     dx,al

pop     di
pop     es
}

/** Assembly function to shift data into JTAG port while not reading **/

void near Shift_Data_Array_IN(unsigned S, char far *D)
{
    /** Shifts data String into JTAG port WITHOUT reading data **/
    /** from JTAG port back into D. **/
    /** The procedure should be called when JTAG controller is in the **/
    /** SelectDRScan state. **/

```


Table A-1. Program Source Code (Sheet 7 of 15)

```

_asm
{
    mov     dx,JTAG
    push   es
    push   di
    les    di, D           // Get string
    cld
    xor    ax,ax
    mov    ax, S ; Get Size
    dec   ax
    mov    cx,ax
    jz    LastClock4

I_Shift4:
    mov    al, byte ptr es:[di]
    shl   al,6
    and   al, notTCKTMS
    out   dx,al           // Put first data bit
    or    al,TCK         // Set TCK high
    out   dx,al           // Shift in first data bit
    inc   di             // Update pointer
    loop  I_Shift4

LastClock4:
    mov    al, byte ptr es:[di]
    shl   al,6
    and   al, notTCKTMS
    or    al, TMS
    out   dx,al           // Put last data bit
    or    al,TCK         // Set TCK high
    out   dx,al           // Shift in last data bit
    mov   al,TDITMS     // Leave TCK pin Low!
    out   dx,al

    pop   di
    pop   es
}
}
/***** Assembly function to pulse STROBE line on parallel ports *****/

void far Strobe_Data_In ()
{
    _asm
    {
        push   dx
        mov    dx,JTAGR
        mov    al,1+TRST // Sets STROBE# bit low for WE# use
        out   dx,al
        mov    al,TRST // Returns STROBE# without RESET#
        out   dx,al
        pop   dx
    }
}
/*****
/***** C++ FUNCTIONS FOR JTAG PROGRAMMING *****/
/*****
/***** Function to send instruction to JTAG *****/

void Send_Instruction (unsigned S, char far *D)
/* Send instruction string into JTAG port, replace */

```

Table A-1. Program Source Code (Sheet 8 of 15)

```

/* the original string with the data that comes out TDO */
{
    TMS_Low();           // Go to Run_Test_Idle
    TMS_Low();           // Go to Run_Test_Idle
    TMS_High();          // Go to Select_DR_Scan
    TMS_High();          // Go to Select_IR_Scan
    TMS_Low();           // Go to Capture_IR
    TMS_Low();           // Go to Shift_IR
    Shift_Data_Array(S,D);
    TMS_High();          // Update_IR, new instr. in effect
    TMS_Low();           // Run_Test_Idle
}
/***** Function to send instruction into JTAG port, do not read TDO *****/
void Send_Instruction_IN (unsigned S, char far *D)
{
    TMS_Low();           // Go to Run_Test_Idle
    TMS_Low();           // Go to Run_Test_Idle
    TMS_High();          // Go To Select_DR_Scan
    TMS_High();          // Go To Select_IR_Scan
    TMS_Low();           // Go to Capture_IR
    TMS_Low();           // Go to Shift_IR }
    Shift_Data_Array_IN(S,D);//
    TMS_High();          // Update_IR, new instr. in effect
    TMS_Low();           // Run_Test_Idle
}
/**** Function to send data string into JTAG port + replace original *****/
void Send_Data (unsigned S, char far *D)
/* Send data string into JTAG port */
/* replace the original string with the data that comes out TDO */
{
    TMS_Low();           // Go to Run_Test_Idle
    TMS_Low();           // Go to Run_Test_Idle
    TMS_High();          // Go To Select_DR_Scan
    TMS_Low();           // Go to Capture_DR
    TMS_Low();           // Go to Shift_DR
    Shift_Data_Array(S,D);
    TMS_High();          // Update_IR, new data is in effect
    TMS_Low();           // Run_Test_Idle
}
/**** Function to send data string into JTAG port w/o replacing orig. *****/
void far Send_Data_IN (unsigned S, char far *D)
/* Send data string into JTAG port, */
/* The original data is not overwritten */
{
    TMS_Low();           // Go to Run_Test_Idle
    TMS_Low();           // Go to Run_Test_Idle
    TMS_High();          // Go To Select_DR_Scan
    TMS_Low();           // Go to Capture_DR
    TMS_Low();           // Go to Shift_DR
    Shift_Data_Array_IN(S,D);
    TMS_High();          // Update_IR, new data is in effect
    TMS_Low();           // Run_Test_Idle
}
/***** Function to invert a data string so MSB is first *****/
void Flip_ID_String (int length, char Input[ID_String_Length])
{
    /* Flips the JTAG Unit ID string */
    /* since it is read in backwards */
}

```

Table A-1. Program Source Code (Sheet 9 of 15)

```

int i,j;
char Temp[ID_String_Length];

j = 0;
for ( i=length; i >= 1; --i)
    {
    Temp[j] = Input[i-1];
    ++j;
    }
for ( i=0; i <= (length-1); ++i)
    Input[i] = Temp[j];
}
/***** Function to get ID string from the Intel(tm)386EX Chip *****/

void Get_JTAG_Device_ID ()
{
    const char *p="01010101010101010101010101010101";
    // Dummy string, will change value
    // after Send_Data executes

    char ID[ID_String_Length];

    strcpy(ID,p);
    Send_Instruction_IN(strlen(IDCODE),IDCODE); // Do NOT overwrite Instr.
    // Because it resides in the
    // Fixed string area!

    Send_Data(strlen(ID),ID);
    Flip_ID_String(strlen(ID),ID); // Makes MSB first in array
    printf("\nThe JTAG CPU Chip Identifier is: %s\n",ID);
    printf
    ("For Intel386(tm)EX it should be: 000000000100111000000000010011\n");
}
/**** Function to fill the JTAG array with zeros and set all as inputs **/

void Fill_JTAG(PJTAGdata P)

/*****
Configures pins for typical configuration:
P15: Out, Low
ADS: Out, Low
BHE: Out, Low
BLE: Out, Low
WR : Out, Don't Care
RD : Out, Don't Care
WRD: Out, Low
DC : Out, High
MIO: Out, High
UCS: Out, Don't Care
LBA: Out, Low
All other entries configured as inputs

Dir Bit Output = i*2
Data Bit = i*2+1
*****/

{
    unsigned i;
    for (i=0;i<=BSR_Length-1;i++)
        P[i] = '0';

    P[P15*2] = '1';
    P[P15*2+1] = '0'; // Make Vpp active to program FLASH
    P[ADS*2] = '1';
    P[ADS*2+1] = '0';
}

```

Table A-1. Program Source Code (Sheet 10 of 15)

```

P[BHE*2] = '1';
P[BHE*2+1] = '0'; // BHE and BLE active for 16 Bit
P[BLE*2] = '1';
P[BLE*2+1] = '0';
P[WR*2] = '1'; // Not necessary to initialize value
P[RD*2] = '1'; // Not necessary to initialize value
P[WRD*2] = '1';
P[WRD*2+1] = '0'; // WRD is Read by default
P[DC*2] = '1';
P[DC*2+1] = '1';
P[MIO*2] = '1';
P[MIO*2+1] = '1';
P[UCS*2] = '1'; // Not necessary to initialize value
P[LBA*2] = '1';
P[LBA*2+1] = '0'; // Enables U8 by fooling PLD
}
/***** Function to Set Data Pins given 16 Bit Data *****/
void Set_Data(PJTAGdata P, word D) /* Sets data onto pins and makes them */
/* into outputs */
{
    int i;
    word M;

    M = 1;

    for (i=D0 ; i>=D15; --i )
    {
        if ((D & M) != FALSE)
            P[i*2+1] = '1';
        else
            P[i*2+1] = '0';
        P[i*2] = '1'; // Data pins are Outputs now
        M <<= 1;
    }
}
/***** Function to set data DIR bits to 0 on 16 bit data bus *****/
void Get_Data(PJTAGdata P) /** Configures data lines as inputs */
{
    int i;

    for ( i=D0; i>=D15; --i)
        P[i*2] = '0'; // Configure as inputs
}
/**** Function to convert JTAG output string into byte *****/
word Parse_Data(PJTAGdata P) /** Reads data lines and returns data word */
{
    int i;
    word M=1,D=0;

    for ( i=D0; i>=(D15); --i) // Reads data lines
    {
        if (P[i*2+1] == '1')
            D=D|M;
        M <<= 1;
    }
    return(D);
}
/***** Function to set the address on the address pins *****/
void Set_Address(PJTAGdata P, unsigned long int Address)

```

Table A-1. Program Source Code (Sheet 11 of 15)

```

/* Sets address lines and makes them into outputs */
int i;
long int M=1;

for (i=A1; i>=A25; --i)
{
    if ((Address & M) != 0)
        P[i*2+1]='1';
    else
        P[i*2+1]='0';
    M <<= 1;
    P[i*2]='1';
}
P[UCS*2+1] = '0';
}
/***** Function to read data from FLASH *****/

word Flash_Read(PJTAGdata P, unsigned long int Address)
{
    Get_Data(P);                // Configure Data Bus as inputs
    Set_Address(P,Address);     // Set addr on bus
    P[UCS*2+1] = '0';          // Selects Flash chip
    P[RD*2+1] = '0';           // RD#=Low Data
    P[WR*2+1] = '1';           // WR#=High Data
    P[WRD*2+1] = '0';         // For Read
    Send_Data_IN(BSR_Length,P);
    // sets data on the Address bus, Data bus in the input mode
    Send_Data(BSR_Length,P);
    // Latches Data bus into BSR and then shifts it out into P
    return(Parse_Data(P));     // Convert result into binary
}
/***** Function to Write Data to Flash *****/

void Flash_Write(PJTAGdata P, unsigned long int A, word D)
{
    Set_Data(P,D);             // Output data on bus
    Set_Address(P,A);          // Output address
    P[UCS*2+1] = '0';         // Selects Flash Chip
    P[RD*2+1] = '1';          // RD#=High Data

// !!!! ONLY ONE OF SECTIONS 1 or 2 MAY BE USED - COMMENT OUT THE OTHER !!!!
// SECTION 1 - USE IF STROBE# IS CONNECTED DIRECTLY TO FLASH_WE# - FASTEST

    Send_Data_IN(BSR_Length,P);
    Strobe_Data_In();         // Clocks the Par. Port STROBE line

// SECTION 2 - USE IF DRAM WE# IS CONNECTED DIRECTLY TO FLASH_WE# - SLOWER
//
// P[WR*2+1] = '1';           // WR#=High Data
// P[WRD*2+1] = '0';         // For Read
// Send_Data_IN(BSR_Length,P); // Can skip if WE# is already High!
// P[WR*2+1] = '0';         // WR#=Low Data
// P[WRD*2+1] = '1';         // For Write access
// Send_Data_IN(BSR_Length,P);
// P[WR*2+1] = '1';         // WR#=High Data again
// P[WRD*2+1] = '0';         // Read access again */
// Send_Data_IN(BSR_Length,P);
}
/***** Function to read input file name and data *****/

int Input_File_Name_OK (char input_file_name[80])
{

```

Table A-1. Program Source Code (Sheet 12 of 15)

```

FILE *in; // Points to the input file

printf ("\nEnter name of input file: ");
scanf ("%80s", input_file_name);

if ( (in = fopen (input_file_name, "rb")) == (FILE *) NULL )
{
    printf ("Could not open %s for input data.\n", input_file_name);
    fclose (in);
    return (FALSE); // File not loaded into memory
}
else
{
    printf ("File name is good ..... continuing..... \n");
    fclose (in);
    return (TRUE); // File is loaded in memory
}
}
/***** Function to retrieve info about FLASH manufacturer and Device *****/

void Get_Flash_Device_ID ()
{
    Send_Instruction_IN(strlen(SAMPLE),SAMPLE); // Sample/Preload to initialize BSR
    Send_Instruction_IN(strlen(EXTEST),EXTEST); // Configure for External Test
    A=0x0; // Initializer
    Flash_Write(PinState,A,0x90); // Send command to flash: read ID
    RX = Flash_Read(PinState,A); // Rd 1 word Flash Device ID
    printf ("\nFlash Chip Intelligent ID reads: %4.4xH",RX); // Print first word
    RX = Flash_Read(PinState,A+1);
    printf (" * %4.4xH\n",RX); // Print second word
    printf ("Flash ID for 28F400-T should be: 0089H * 4470H\n");
}
/**** Function checks FLASH status register and displays the contents *****/

void Check_Flash_Status ()
{
    Flash_Write(PinState,A,0x50); // Clears Status Registers
    Flash_Write(PinState,A,0x70); // Send command to flash: RD Status
    RX = Flash_Read(PinState, A);
    printf ("\nStatus of the FLASH part is: %4.4xH\n",RX);
    printf ("FLASH status should be read: 0080H\n");
}
/***** Function to erase the contents of the entire FLASH chip *****/

void Erase_Flash ()
{
    int index;
    unsigned long int blocks[] =
        {0x0000,0x10000,0x20000,0x30000,0x3C000,0x3D000,0x3E000};
        // Above = Starting *word* address of
        // each of the blocks in a 28F400BV-T

    printf ("\nNow Erasing FLASH.....Please be patient.....\n");
    for (index=0; index<=6; index++)
    {
        A=blocks[index];
        Flash_Write(PinState,A,0x20);
        Flash_Write(PinState,A,0xD0); // Wait until Erase Complete
    }
}

```

Table A-1. Program Source Code (Sheet 13 of 15)

```

Flash_Write(PinState,A,0x70); // Check Status Register
RX = Flash_Read(PinState,A);
}
while ((RX & 0x80) == FALSE); // Wait Until Ready again

printf("Status of FLASH block #x is: %4.4xH\n", index+1,RX);
Flash_Write(PinState,A,0x50); // Clears Status Registers for next
} // block erase
printf("FLASH status should be read: 0080H\n");
printf("FLASH has been erased.....Ready to write data.... \n");
}
/***** Function to program the data in the file into the FLASH *****/
unsigned long int Program_Flash_Data () /* Code below outputs data from */
{ /* binary file to the FLASH. Outputs words. */

A = data_start_address >> 1; // So that starting point can be remembered
in = fopen (input_file, "rb");
printf("\nWriting input file data into FLASH... \n");
printf("Please be patient... May take 2-10 seconds per kilobyte.\n");
while ((c = fgetc(in)) != EOF)
{
new_word = 0; // Code to make a word from two chars
new_word = (new_word | c); // Initializes the two byte word
c = fgetc(in); // Puts first byte into low 8 bits
high_part = 0; // Gets second bytes
high_part = (high_part | c); // Initializes temporary space
high_part = high_part << 8; // Puts second byte into low 8 bits
new_word = (new_word | high_part); // Shifts second byte up 8 bits to top
// Combines low 8 and high

Flash_Write(PinState,A,0x40); // Program set-up command
Flash_Write(PinState,A,new_word); // Writes 16 bit word

// May add the following section to do status checks for each write
// Not necessary for the very slow speed of parallel port.
// Will severely inhibit performance.

// do
// {
// Flash_Write(PinState,A,0x70); // Check Status Register
// RX = Flash_Read(PinState,A); // for each word ....
// }
// while ((RX & 0x80) == FALSE); // Wait Until Ready again

++A; // Increments address in word mode
}
printf("File has been sucessfully read from disk.\n");
printf("Data programmed at hex byte location %lxH\n", data_start_address);

if (fclose (in))
printf ("The file %s was not closed successfully.\n", input_file);
else
printf ("The file %s was closed successfully.\n", input_file);
return (A - (data_start_address >> 1));
}
/***** Function to read the upper 32k of FLASH for Debug *****/
void Read_FLASH_Data (char *FileName,
unsigned long int AStart,
unsigned long int Size)
/* Reads 16 bit words from FLASH chip into binary file starting @ Astart */
{

```

Table A-1. Program Source Code (Sheet 14 of 15)

```

FILE *DataFile;
unsigned long int Address;
word Data;

printf("\nNow reading back data for verification of program success...\n");
printf("Please be patient. May take up to 2 seconds per kilobyte....\n");

printf("\nFile starting location in FLASH is %lxH\n", AStart);
printf("File ending location in FLASH is  %lxH\n", AStart+(Size<1));

Flash_Write(PinState,A,0xFF);          // Sets up to read back data
DataFile = fopen(FileName, "w+b");
AStart = AStart >> 1;                  // For word access addressing
for (Address = AStart; Address < AStart+Size; Address++)
{
    Data=Flash_Read(PinState,Address);
    if (fwrite(&Data, sizeof(Data),1,DataFile) != 1)
        printf("problem writing to file");
}
fclose(DataFile);
printf
("\nFile verification image has been written to file "VERIFY.BIN"...\n");
printf
("WARNING: Verification file will contain one extra byte for\n");
printf
("input files with odd byte counts.\n");
}
/*****
/***** BEGIN MAIN *****/
/*****/

void main ()
{
if (Input_File_Name_OK (input_file))
{
printf          // On next line...
("\n***** INTEL i386EX PROGRAMS FLASH VIA THE JTAG PORT *****\n");
Fill_JTAG(PinState);          // Initialization string
Reset_JTAG();                // Reset the JTAG unit
                          // Reset board while TRST# is low
                          // to insure proper startup
printf("\nWARNING: Reset Evaluation Board now and press any key.\n");
while (!_kbhit());           // Waits until a key is hit
_getch();                    // Throws away character
Restore_Idle();              // Used to reset JTAG state machine
Get_JTAG_Device_ID();        // Get ID - see 386EX manual for code
Get_Flash_Device_ID();       // Get ID - see flash manual
Check_Flash_Status();        // Check status register example
Erase_Flash();               // Erases the entire Flash chip
printf("\nEnter starting address of program data in hex bytes: ");
scanf("%lx",&data_start_address); // Scans starting address in hex
                          // Uses word mode below
i = Program_Flash_Data();     // Opens file and programs FLASH data

Check_Flash_Status();        // Checks status before continuing
Read_FLASH_Data("verify.bin", data_start_address, i); // Copy contents to
                          // file to verify OK
printf("\nThe board must now be reset to return to normal operation.");
                          // Reset board while TRST# is low
                          // to insure proper startup
printf("\nWARNING: Reset Evaluation Board now and press any key.\n");
while (!_kbhit());           // Waits until a key is hit
}
}

```




APPENDIX B Intel386™ EX Embedded Processor BSDL File

The following BSDL file for the A and B steppings of the Intel386 EX embedded processor is located on Intel's America's Application Support BBS, at (916) 356-3600. It is contained in the zipped file called JTAGBSDL.ZIP located in the Intel386™ EX embedded processor area.

Table B-1. BSDL File (Sheet 1 of 10)

```
-- Copyright Intel Corporation 1994
*****
-- Intel Corporation makes no warranty for the use of its products
-- and assumes no responsibility for any errors which may appear in
-- this document nor does it make a commitment to update the information
-- contained herein.
*****
-- Boundary-Scan Description Language (BSDL Version 0.0) is a de-facto
-- standard means of describing essential features of ANSI/IEEE 1149.1-1993
-- compliant devices. This language is under consideration by the IEEE for
-- formal inclusion within a supplement to the 1149.1-1990 standard. The
-- generation of the supplement entails an extensive IEEE review and a formal
-- acceptance balloting procedure which may change the resultant form of the
-- language. Be aware that this process may extend well into 1993, and at
-- this time the IEEE does not endorse or hold an opinion on the language.
*****
--
-- Intel386 (TM) EX Processor BSDL Model
-- File **NOT** verified electrically
-----
-- Rev 0.4          14 Sep 1994

--The following list describes all of the pins that are contained in the E3D

entity i386_EX_Processor is
  generic(PHYSICAL_PIN_MAP : string := "PQFP_132");

port(
D15      :          inout bit;
D14      :          inout bit;
D13      :          inout bit;
D12      :          inout bit;
D11      :          inout bit;
D10      :          inout bit;
D9       :          inout bit;
D8       :          inout bit;
D7       :          inout bit;
D6       :          inout bit;
D5       :          inout bit;
D4       :          inout bit;
D3       :          inout bit;
D2       :          inout bit;
D1       :          inout bit;
D0       :          inout bit;
```

Table B-1. BSDL File (Sheet 2 of 10)

LBAbbar	:	inout bit;
LCSbbar	:	inout bit;
UCSbbar	:	inout bit;
P27XCTS0	:	inout bit;
P26XTXD0	:	inout bit;
P25XRXD0	:	inout bit;
DACK0barXGCS5bar	:	inout bit;
P24XGCS4bar	:	inout bit;
P23XGCS3bar	:	inout bit;
P22XGCS2bar	:	inout bit;
P21XGCS1bar	:	inout bit;
P20XGCS0bar	:	inout bit;
SMIACTbarXEXCSIG	:	inout bit;
DRQ1XRXD1	:	inout bit;
DRQ0XDCD1bar	:	inout bit;
WDTOUT	:	inout bit;
EOPbarXCTS1bar	:	inout bit;
DACK1barXTXD1	:	inout bit;
P17XHLDA	:	inout bit;
RESET	:	inout bit;
P16XHOLD	:	inout bit;
P15XLOCKbar	:	inout bit;
P14XRIObbar	:	inout bit;
P13XDSR0bar	:	inout bit;
P12XDTR0bar	:	inout bit;
P11XRTS0bar	:	inout bit;
P10XDCD0bar	:	inout bit;
FLTbar	:	inout bit;
DSR1barXSTXCLK	:	inout bit;
INT7XTMRGATE1	:	inout bit;
INT6XTMRCLK1	:	inout bit;
INT5XTMRGATE0	:	inout bit;
INT4XTMRCLK0	:	inout bit;
BUSYbarXTMRGATE2	:	inout bit;
ERRORbarXTMROUT2	:	inout bit;
NMI	:	inout bit;
PEREQXTMRCLK2	:	inout bit;
P37XCOMCLK	:	inout bit;
P36XPWRDOWN	:	inout bit;
P35XINT3	:	inout bit;
P34XINT2	:	inout bit;
P33XINT1	:	inout bit;
P32XINT0	:	inout bit;
RTS1barXSSIOTX	:	inout bit;
RI1barXSSIORX	:	inout bit;
DTR1barXSRXCLK	:	inout bit;
P31XTMROUT1	:	inout bit;
P30XTMROUT0	:	inout bit;
SMIbbar	:	inout bit;
A25	:	inout bit;
A24	:	inout bit;
A23	:	inout bit;
A22	:	inout bit;
A21	:	inout bit;
A20	:	inout bit;

Table B-1. BSDL File (Sheet 3 of 10)

```

A19      :          inout bit;
A18XCAS2 :          inout bit;
A17XCAS1 :          inout bit;
A16XCAS0 :          inout bit;
A15      :          inout bit;
A14      :          inout bit;
A13      :          inout bit;
A12      :          inout bit;
A11      :          inout bit;
A10      :          inout bit;
A9       :          inout bit;
A8       :          inout bit;
A7       :          inout bit;
A6       :          inout bit;
A5       :          inout bit;
A4       :          inout bit;
A3       :          inout bit;
A2       :          inout bit;
A1       :          inout bit;
NAbar    :          inout bit;
ADSbar   :          inout bit;
BHEbar   :          inout bit;
BLEbar   :          inout bit;
WRbar    :          inout bit;
RDbar    :          inout bit;
BS8bar   :          inout bit;
READYbar :          inout bit;
WXRbar   :          inout bit;
DXCbar   :          inout bit;
MXIObar  :          inout bit;
TCK      :          in bit;
TDI      :          in bit;
TMS      :          in bit;
TRSTbar  :          in bit;
TDO      :          out bit;
VCC      :          linkage bit_vector(0 to 10);
VSS      :          linkage bit_vector(0 to 12));

use STD_1149_1_1990.all;

--This list describes the physical pin layout of all signals

attribute PIN_MAP of i386_EX_Processor : entity is PHYSICAL_PIN_MAP;
constant PQFP_132 : PIN_MAP_STRING := -- Define PinOut of PQFP
    "D15      : 23," &
    "D14      : 22," &
    "D13      : 21," &
    "D12      : 20," &
    "D11      : 19," &
    "D10      : 18," &
    "D9       : 16," &
    "D8       : 14," &
    "D7       : 13," &

```

Table B-1. BSDL File (Sheet 4 of 10)

"D6	:	12,"&
"D5	:	11,"&
"D4	:	10,"&
"D3	:	8,"&
"D2	:	7,"&
"D1	:	6,"&
"D0	:	5,"&
"LBAbar	:	4,"&
"LCSbar	:	2,"&
"UCSbar	:	1,"&
"P27XCTS0	:	132,"&
"P26XTXD0	:	131,"&
"P25XRXD0	:	129,"&
"DACK0barXGCS5bar	:	128,"&
"P24XGCS4bar	:	126,"&
"P23XGCS3bar	:	125,"&
"P22XGCS2bar	:	124,"&
"P21XGCS1bar	:	123,"&
"P20XGCS0bar	:	122,"&
"SMIACTbarXEXCSIG	:	120,"&
"DRQ1XRXD1	:	118,"&
"DRQ0XDCD1bar	:	117,"&
"WDTOUT	:	114,"&
"EOPbarXCTS1bar	:	113,"&
"DACK1barXTXD1	:	112,"&
"P17XHLDA	:	111,"&
"RESET	:	110,"&
"P16XHOLD	:	108,"&
"P15XLOCKbar	:	107,"&
"P14XRIObar	:	106,"&
"P13XDSR0bar	:	105,"&
"P12XDTR0bar	:	104,"&
"P11XRTS0bar	:	102,"&
"P10XDCD0bar	:	101,"&
"FLTbar	:	99,"&
"DSR1barXSTXCLK	:	98,"&
"INT7XTMRGATE1	:	96,"&
"INT6XTMRCLK1	:	95,"&
"INT5XTMRGATE0	:	94,"&
"INT4XTMRCLK0	:	93,"&
"BUSYbarXTMRGATE2	:	92,"&
"ERRORbarXTMROUT2	:	91,"&
"NMI	:	90,"&
"PEREQXTMRCLK2	:	89,"&
"P37XCOMCLK	:	87,"&
"P36XPWRDOWN	:	86,"&
"P35XINT3	:	85,"&
"P34XINT2	:	84,"&
"P33XINT1	:	82,"&
"P32XINT0	:	80,"&
"RTS1barXSSIOTX	:	79,"&
"RI1barXSSIORX	:	78,"&
"DTR1barXSRXCLK	:	77,"&
"P31XTMROUT1	:	75,"&
"P30XTMROUT0	:	74,"&

Table B-1. BSDL File (Sheet 5 of 10)

```

"SMIbar      : 73,"&
"A25        : 72,"&
"A24        : 70,"&
"A23        : 68,"&
"A22        : 67,"&
"A21        : 66,"&
"A20        : 65,"&
"A19        : 63,"&
"A18XCAS2   : 62,"&
"A17XCAS1   : 61,"&
"A16XCAS0   : 59,"&
"A15        : 58,"&
"A14        : 57,"&
"A13        : 56,"&
"A12        : 55,"&
"A11        : 54,"&
"A10        : 53,"&
"A9         : 52,"&
"A8         : 51,"&
"A7         : 50,"&
"A6         : 49,"&
"A5         : 48,"&
"A4         : 45,"&
"A3         : 44,"&
"A2         : 43,"&
"A1         : 42,"&
"NAbar      : 41,"&
"ADSbar     : 40,"&
"BHEbar     : 39,"&
"BLEbar     : 37,"&
"WRbar      : 35,"&
"RDbar      : 34,"&
"BS8bar     : 33,"&
"READYbar   : 32,"&
"WXRbar     : 30,"&
"DXCbar     : 29,"&
"MXIObar    : 27,"&
"TRSTbar    : 119,"&
"TDO        : 24,"&
"TDI        : 25,"&
"TMS        : 26,"&
"TCK        : 76,"&
"VCC        : (15,28,38,47,60,71,81,88,109,121,127),"&
"VSS        : (3,17,31,36,46,64,69,83,97,100,103,116,130)";

attribute Tap_Scan_In of TDI : signal is true;
attribute Tap_Scan_Mode of TMS : signal is true;
attribute Tap_Scan_Out of TDO : signal is true;
attribute Tap_Scan_Reset of TRSTBAR : signal is true;
attribute Tap_Scan_Clock of TCK : signal is (33.0e6, BOTH);

attribute Instruction_Length of i386_EX_Processor: entity is 4;

attribute Instruction_Opcode of i386_EX_Processor: entity is

"BYPASS      (1111)," &

```

Table B-1. BSDL File (Sheet 6 of 10)

```

"EXTEST      (0000)," &
"SAMPLE      (0001)," &
"IDCODE      (0010)," &
"HIGHZ       (1000)," &
"Reserved    (1100, 1011)";
-- Private instructions DO NOT belong in BSDL

attribute Instruction_Capture of i386_EX_Processor: entity is "0001";
-- there is no Instruction_Disable attribute for i386_EX_Processor

attribute Instruction_Private of i386_EX_Processor: entity is "Reserved" ;

attribute Idcode_Register of i386_EX_Processor: entity is
"0000"          & --version,
"0000001001110000" & --part number ??
"00000001001"   & --manufacturers identity
"1";            --required by the standard

attribute Register_Access of i386_EX_Processor: entity is
"Bypass                                     (HIGHZ)";

--{*****}
--{ The first cell, cell 0, is closest to TDO }
--{*****}

attribute Boundary_Cells of i386_EX_Processor: entity is "BC_6, BC_2";

attribute Boundary_Length of i386_EX_Processor: entity is 202;
attribute Boundary_Register of i386_EX_Processor: entity is
"0 (BC_2, *, control, 0)," &
"1 (BC_6, D15, bidir, X, 0, 0, Z)," &
"2 (BC_2, *, control, 0)," &
"3 (BC_6, D14, bidir, X, 2, 0, Z)," &
"4 (BC_2, *, control, 0)," &
"5 (BC_6, D13, bidir, X, 4, 0, Z)," &
"6 (BC_2, *, control, 0)," &
"7 (BC_6, D12, bidir, X, 6, 0, Z)," &
"8 (BC_2, *, control, 0)," &
"9 (BC_6, D11, bidir, X, 8, 0, Z)," &
"10 (BC_2, *, control, 0)," &
"11 (BC_6, D10, bidir, X, 10, 0, Z)," &
"12 (BC_2, *, control, 0)," &
"13 (BC_6, D9, bidir, X, 12, 0, Z)," &
"14 (BC_2, *, control, 0)," &
"15 (BC_6, D8, bidir, X, 14, 0, Z)," &
"16 (BC_2, *, control, 0)," &
"17 (BC_6, D7, bidir, X, 16, 0, Z)," &
"18 (BC_2, *, control, 0)," &
"19 (BC_6, D6, bidir, X, 18, 0, Z)," &
"20 (BC_2, *, control, 0)," &
"21 (BC_6, D5, bidir, X, 20, 0, Z)," &
"22 (BC_2, *, control, 0)," &
"23 (BC_6, D4, bidir, X, 22, 0, Z)," &
"24 (BC_2, *, control, 0)," &
"25 (BC_6, D3, bidir, X, 24, 0, Z)," &

```


Table B-1. BSDL File (Sheet 7 of 10)

"26	(BC_2, *, control, 0)," &
"27	(BC_6, D2, bidir, X, 26, 0, Z)," &
"28	(BC_2, *, control, 0)," &
"29	(BC_6, D1, bidir, X, 28, 0, Z)," &
"30	(BC_2, *, control, 0)," &
"31	(BC_6, D0, bidir, X, 30, 0, Z)," &
"32	(BC_2, *, control, 0)," &
"33	(BC_6, LBAbar, bidir, X, 32, 0, Z)," &
"34	(BC_2, *, control, 0)," &
"35	(BC_6, LCSbar, bidir, X, 34, 0, Z)," &
"36	(BC_2, *, control, 0)," &
"37	(BC_6, UCSbar, bidir, X, 36, 0, Z)," &
"38	(BC_2, *, control, 0)," &
"39	(BC_6, P27XCTS0, bidir, X, 38, 0, Z)," &
"40	(BC_2, *, control, 0)," &
"41	(BC_6, P26XTXD0, bidir, X, 40, 0, Z)," &
"42	(BC_2, *, control, 0)," &
"43	(BC_6, P25XRXD0, bidir, X, 42, 0, Z)," &
"44	(BC_2, *, control, 0)," &
"45	(BC_6, DACK0barXGCS5bar, bidir, X, 44, 0, Z)," &
"46	(BC_2, *, control, 0)," &
"47	(BC_6, P24XGCS4bar, bidir, X, 46, 0, Z)," &
"48	(BC_2, *, control, 0)," &
"49	(BC_6, P23XGCS3bar, bidir, X, 48, 0, Z)," &
"50	(BC_2, *, control, 0)," &
"51	(BC_6, P22XGCS2bar, bidir, X, 50, 0, Z)," &
"52	(BC_2, *, control, 0)," &
"53	(BC_6, P21XGCS1bar, bidir, X, 52, 0, Z)," &
"54	(BC_2, *, control, 0)," &
"55	(BC_6, P20XGCS0bar, bidir, X, 54, 0, Z)," &
"56	(BC_2, *, control, 0)," &
"57	(BC_6, SMIACTbarXEXCSIG, bidir, X, 56, 0, Z)," &
"58	(BC_2, *, control, 0)," &
"59	(BC_6, DRQ1XRXD1, bidir, X, 58, 0, Z)," &
"60	(BC_2, *, control, 0)," &
"61	(BC_6, DRQ0XDCD1bar, bidir, X, 60, 0, Z)," &
"62	(BC_2, *, control, 0)," &
"63	(BC_6, WDOUT, bidir, X, 62, 0, Z)," &
"64	(BC_2, *, control, 0)," &
"65	(BC_6, EOPbarXCTS1bar, bidir, X, 64, 0, Z)," &
"66	(BC_2, *, control, 0)," &
"67	(BC_6, DACK1barXTXD1, bidir, X, 66, 0, Z)," &
"68	(BC_2, *, control, 0)," &
"69	(BC_6, P17XHLDA, bidir, X, 68, 0, Z)," &
"70	(BC_2, *, control, 0)," &
"71	(BC_6, RESET, bidir, X, 70, 0, Z)," &
"72	(BC_2, *, control, 0)," &
"73	(BC_6, P16XHOLD, bidir, X, 72, 0, Z)," &
"74	(BC_2, *, control, 0)," &
"75	(BC_6, P15XLOCKbar, bidir, X, 74, 0, Z)," &
"76	(BC_2, *, control, 0)," &
"77	(BC_6, P14XRIObar, bidir, X, 76, 0, Z)," &
"78	(BC_2, *, control, 0)," &
"79	(BC_6, P13XDSR0bar, bidir, X, 78, 0, Z)," &
"80	(BC_2, *, control, 0)," &
"81	(BC_6, P12XDTR0bar, bidir, X, 80, 0, Z)," &

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"82	(BC_2, *, control, 0)," &
"83	(BC_6, P11XRTS0bar, bidir, X, 82, 0, Z)," &
"84	(BC_2, *, control, 0)," &
"85	(BC_6, P10XDCD0bar, bidir, X, 84, 0, Z)," &
"86	(BC_2, *, control, 0)," &
"87	(BC_6, FLTbar, bidir, X, 86, 0, Z)," &
"88	(BC_2, *, control, 0)," &
"89	(BC_6, DSRLbarXSTXCLK, bidir, X, 88, 0, Z)," &
"90	(BC_2, *, control, 0)," &
"91	(BC_6, INT7XTMRGATE1, bidir, X, 90, 0, Z)," &
"92	(BC_2, *, control, 0)," &
"93	(BC_6, INT6XTMRCLK1, bidir, X, 92, 0, Z)," &
"94	(BC_2, *, control, 0)," &
"95	(BC_6, INT5XTMRGATE0, bidir, X, 94, 0, Z)," &
"96	(BC_2, *, control, 0)," &
"97	(BC_6, INT4XTMRCLK0, bidir, X, 96, 0, Z)," &
"98	(BC_2, *, control, 0)," &
"99	(BC_6, BUSYbarXTMRGATE2, bidir, X, 98, 0, Z)," &
"100	(BC_2, *, control, 0)," &
"101	(BC_6, ERRORbarXTMROUT2, bidir, X, 100, 0, Z)," &
"102	(BC_2, *, control, 0)," &
"103	(BC_6, NMI, bidir, X, 102, 0, Z)," &
"104	(BC_2, *, control, 0)," &
"105	(BC_6, PEREQXTMRCLK2, bidir, X, 104, 0, Z)," &
"106	(BC_2, *, control, 0)," &
"107	(BC_6, P37XCOMCLK, bidir, X, 106, 0, Z)," &
"108	(BC_2, *, control, 0)," &
"109	(BC_6, P36XPWRDOWN, bidir, X, 108, 0, Z)," &
"110	(BC_2, *, control, 0)," &
"111	(BC_6, P35XINT3, bidir, X, 110, 0, Z)," &
"112	(BC_2, *, control, 0)," &
"113	(BC_6, P34XINT2, bidir, X, 112, 0, Z)," &
"114	(BC_2, *, control, 0)," &
"115	(BC_6, P33XINT1, bidir, X, 114, 0, Z)," &
"116	(BC_2, *, control, 0)," &
"117	(BC_6, P32XINT0, bidir, X, 116, 0, Z)," &
"118	(BC_2, *, control, 0)," &
"119	(BC_6, RTS1barXSSIOTX, bidir, X, 118, 0, Z)," &
"120	(BC_2, *, control, 0)," &
"121	(BC_6, RI1barXSSIORX, bidir, X, 120, 0, Z)," &
"122	(BC_2, *, control, 0)," &
"123	(BC_6, DTR1barXSRXCLK, bidir, X, 122, 0, Z)," &
"124	(BC_2, *, control, 0)," &
"125	(BC_6, P31XTMROUT1, bidir, X, 124, 0, Z)," &
"126	(BC_2, *, control, 0)," &
"127	(BC_6, P30XTMROUT0, bidir, X, 126, 0, Z)," &
"128	(BC_2, *, control, 0)," &
"129	(BC_6, SM1bar, bidir, X, 128, 0, Z)," &
"130	(BC_2, *, control, 0)," &
"131	(BC_6, A25, bidir, X, 130, 0, Z)," &
"132	(BC_2, *, control, 0)," &
"133	(BC_6, A24, bidir, X, 132, 0, Z)," &
"134	(BC_2, *, control, 0)," &
"135	(BC_6, A23, bidir, X, 134, 0, Z)," &
"136	(BC_2, *, control, 0)," &

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"137	(BC_6, A22, bidir, X, 136, 0, Z),"	&
"138	(BC_2, *, control, 0),"	&
"139	(BC_6, A21, bidir, X, 138, 0, Z),"	&
"140	(BC_2, *, control, 0),"	&
"141	(BC_6, A20, bidir, X, 140, 0, Z),"	&
"142	(BC_2, *, control, 0),"	&
"143	(BC_6, A19, bidir, X, 142, 0, Z),"	&
"144	(BC_2, *, control, 0),"	&
"145	(BC_6, A18XCAS2, bidir, X, 144, 0, Z),"	&
"146	(BC_2, *, control, 0),"	&
"147	(BC_6, A17XCAS1, bidir, X, 146, 0, Z),"	&
"148	(BC_2, *, control, 0),"	&
"149	(BC_6, A16XCAS0, bidir, X, 148, 0, Z),"	&
"150	(BC_2, *, control, 0),"	&
"151	(BC_6, A15, bidir, X, 150, 0, Z),"	&
"152	(BC_2, *, control, 0),"	&
"153	(BC_6, A14, bidir, X, 152, 0, Z),"	&
"154	(BC_2, *, control, 0),"	&
"155	(BC_6, A13, bidir, X, 154, 0, Z),"	&
"156	(BC_2, *, control, 0),"	&
"157	(BC_6, A12, bidir, X, 156, 0, Z),"	&
"158	(BC_2, *, control, 0),"	&
"159	(BC_6, A11, bidir, X, 158, 0, Z),"	&
"160	(BC_2, *, control, 0),"	&
"161	(BC_6, A10, bidir, X, 160, 0, Z),"	&
"162	(BC_2, *, control, 0),"	&
"163	(BC_6, A9, bidir, X, 162, 0, Z),"	&
"164	(BC_2, *, control, 0),"	&
"165	(BC_6, A8, bidir, X, 164, 0, Z),"	&
"166	(BC_2, *, control, 0),"	&
"167	(BC_6, A7, bidir, X, 166, 0, Z),"	&
"168	(BC_2, *, control, 0),"	&
"169	(BC_6, A6, bidir, X, 168, 0, Z),"	&
"170	(BC_2, *, control, 0),"	&
"171	(BC_6, A5, bidir, X, 170, 0, Z),"	&
"172	(BC_2, *, control, 0),"	&
"173	(BC_6, A4, bidir, X, 172, 0, Z),"	&
"174	(BC_2, *, control, 0),"	&
"175	(BC_6, A3, bidir, X, 174, 0, Z),"	&
"176	(BC_2, *, control, 0),"	&
"177	(BC_6, A2, bidir, X, 176, 0, Z),"	&
"178	(BC_2, *, control, 0),"	&
"179	(BC_6, A1, bidir, X, 178, 0, Z),"	&
"180	(BC_2, *, control, 0),"	&
"181	(BC_6, NAbar, bidir, X, 180, 0, Z),"	&
"182	(BC_2, *, control, 0),"	&
"183	(BC_6, ADSbar, bidir, X, 182, 0, Z),"	&
"184	(BC_2, *, control, 0),"	&
"185	(BC_6, BHEbar, bidir, X, 184, 0, Z),"	&
"186	(BC_2, *, control, 0),"	&
"187	(BC_6, BLEbar, bidir, X, 186, 0, Z),"	&
"188	(BC_2, *, control, 0),"	&
"189	(BC_6, WRbar, bidir, X, 188, 0, Z),"	&
"190	(BC_2, *, control, 0),"	&
"191	(BC_6, RDbar, bidir, X, 190, 0, Z),"	&
"192	(BC_2, *, control, 0),"	&

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"193 (BC_6, BS8bar, bidir, X, 192, 0, Z)," &  
"194 (BC_2, *, control, 0)," &  
"195 (BC_6, READYbar, bidir, X, 194, 0, Z)," &  
"196 (BC_2, *, control, 0)," &  
"197 (BC_6, WXRbar, bidir, X, 196, 0, Z)," &  
"198 (BC_2, *, control, 0)," &  
"199 (BC_6, DXCbar, bidir, X, 198, 0, Z)," &  
"200 (BC_2, *, control, 0)," &  
"201 (BC_6, MXIObar, bidir, X, 200, 0, Z)";  
  
end i386_EX_Processor;
```

